TEST LOG



Article number: 131760WS004	Sprache Language C)DE	ONL OES OPL
Internal number:	Serial number:	Date:	02.11.2023
Device status:	Remarks:		
As good as new unused			
Damaged (light) technically inspected			
Damaged (dents/scratches) technically checked	1		
Signs of wear (light) technically checked			
Traces of use technically checked			
Packaging:			
Original packaging			
Original packaging (damaged)			
Substitute packaging			

Trade fair / customer return, technically checked and fully functional. Unit may show slight signs of use and/or slight packaging damage.